

Silicon N-Channel Planar Power MOSFET

Description

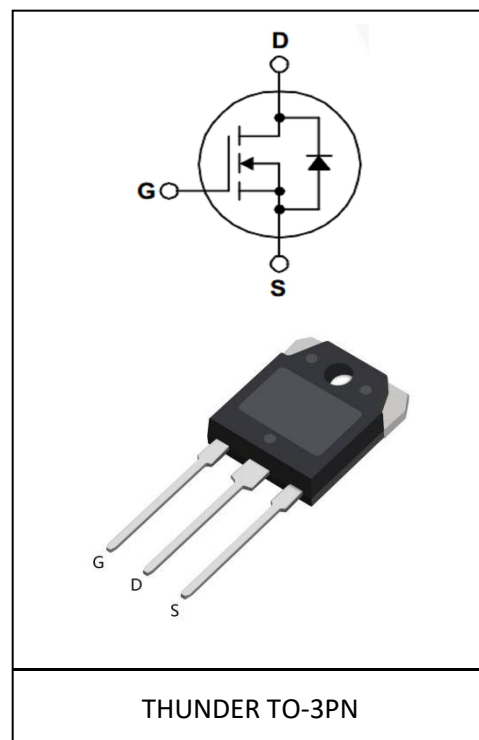
The TH40N65PB utilizes the latest processing techniques to achieve low on-resistance per silicon area. Additional features of this MOSFET are 150°C operating junction temperature and high repetitive peak current capability. These features combine to make this MOSFET a highly efficient, robust and reliable device for PDP driving applications. It can be used in a wide variety of applications.

General Features

- $V_{DS}=650V, I_D=40A$
- Low ON Resistance, $R_{DS(ON)}=207m\Omega @ V_{GS}=10V, I_D=20A$
- Low reverse transfer capacitance
- Low Qg for fast response
- Short fall & rise times for fast switching
- 100% single pulse avalanche energy Test

Application

- Power switching application
- Digital amplifier
- Adapter and charger



Product Summary

V_{DS}	650V
$R_{DS(on)}$	207mΩ
I_D	40A

Absolute Maximum Ratings

Parameter	Symbol	Value	Unit
Drain-source voltage	V_{DS}	650	V
Continuous drain current $T_C = 25^\circ C$ (Silicon limit)	I_D	40	A
Pulsed drain current ($T_C = 25^\circ C$, t_p limited by T_{jmax})	I_{DM}	160	A
Avalanche energy, single pulse ($L=10mH$, $R_g=25\Omega$)	E_{AS}	1172	mJ
Gate-Source voltage	V_{GS}	± 30	V
Power dissipation ($T_C = 25^\circ C$)	P_D	962	W
Operating junction and storage temperature	T_j, T_{stg}	-55...+150	°C

Thermal Resistance

Parameter	Symbol	Max	Unit
Thermal resistance, junction – case.	R_{thJC}	0.13	°C/W
Thermal resistance, junction – ambient(min. footprint)	R_{thJA}	50	

Electrical Characteristic (at $T_j = 25\text{ }^{\circ}\text{C}$, unless otherwise specified)

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		

Static Characteristic

Drain-source breakdown voltage	BV_{DSS}	650	-	-	V	$V_{GS}=0V, I_D=250\mu A$
Gate threshold voltage	$V_{GS(th)}$	2.0	-	4.0	V	$V_{DS}=V_{GS}, I_D=250\mu A$
Zero gate voltage drain current	I_{DSS}	-	-	1	μA	$V_{DS}=650V, V_{GS}=0V$ $T_j=25^{\circ}\text{C}$
		-	-	10	μA	$V_{DS}=520V, V_{GS}=0V$ $T_j=125^{\circ}\text{C}$
Gate-source leakage current	I_{GSS}	-	-	± 100	nA	$V_{GS}=\pm 30V, V_{DS}=0V$
Drain-source on-state resistance	$R_{DS(on)}$	-	207	248	m Ω	$V_{GS}=10V, I_D=20A$

Dynamic Characteristic

Input Capacitance	C_{iss}	-	7438	-	pF	$V_{GS}=0V, V_{DS}=25V$ $f=1\text{MHz}$
Output Capacitance	C_{oss}	-	422	-		
Reverse Transfer Capacitance	C_{rss}	-	22	-		
Gate Total Charge	Q_g	-	88	-	nC	$V_{GS}=10V, V_{DS}=520V$ $I_D=40A$
Gate-Source charge	Q_{gs}	-	20	-		
Gate-Drain charge	Q_{gd}	-	22	-		
Turn-on delay time	$t_{d(on)}$	-	35	-	ns	$V_{DD}=325V, I_D=40A$ $R_G=25\Omega$
Rise time	t_r	-	43	-		
Turn-off delay time	$t_{d(off)}$	-	78	-		
Fall time	t_f	-	50	-		
Gate resistance	R_G	-	0.6	-	Ω	$V_{GS}=0V, V_{DS}=0V$ $f=1\text{MHz}$

Body Diode Characteristic

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		
Body Diode Forward Voltage	V_{SD}	-	-	1.4	V	$V_{GS}=0V, I_{DS}=40A$
Body Diode Continuous Forward Current	I_S	-	-	40	A	$T_C=25^{\circ}C$
Body Diode Reverse Recovery Time	t_{rr}	-	590	-	ns	$T_C=25^{\circ}C, I_S=40A$ $di/dt=100A/us$
Body Diode Reverse Recovery Charge	Q_{rr}	-	5.8	-	μC	

Typical Performance Characteristics

Fig 1: Output Characteristics

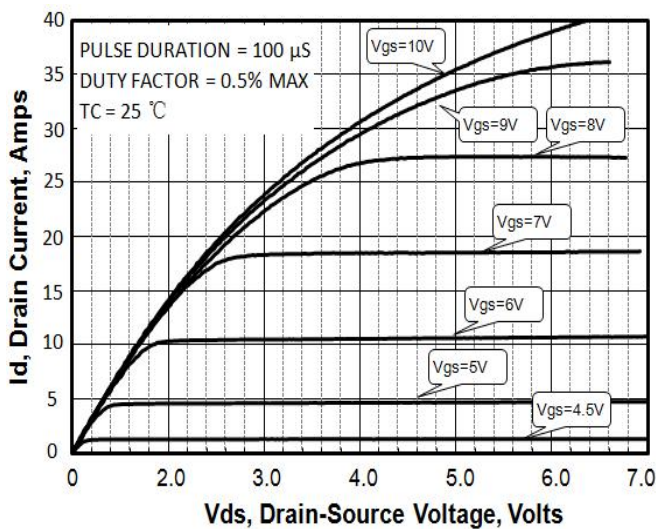


Fig 2: Transfer Characteristics

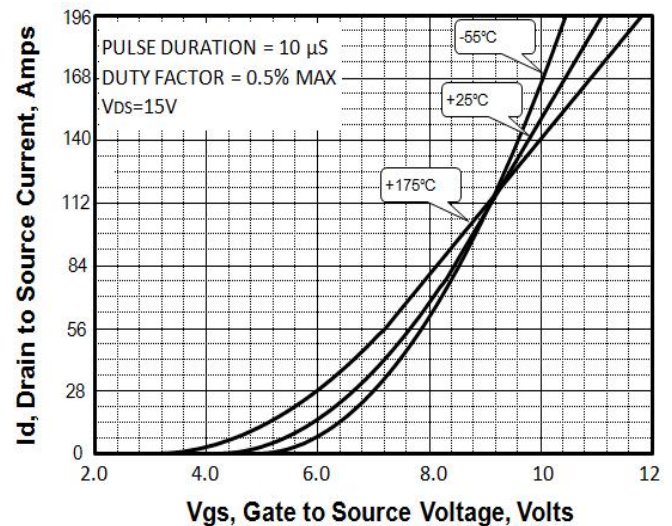


Fig 3: $R_{ds(on)}$ vs. Temperature

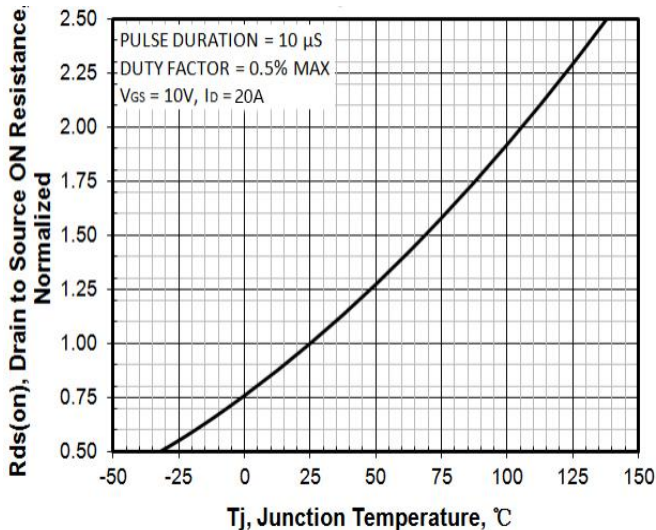


Fig 4: Capacitance Characteristics

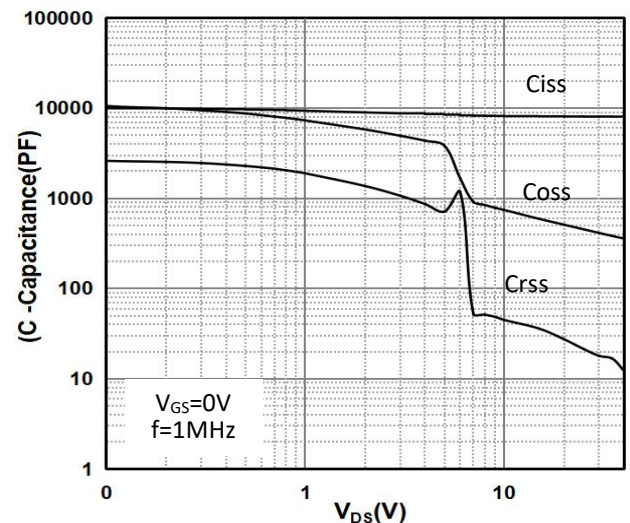


Fig 5: Gate Charge Characteristics

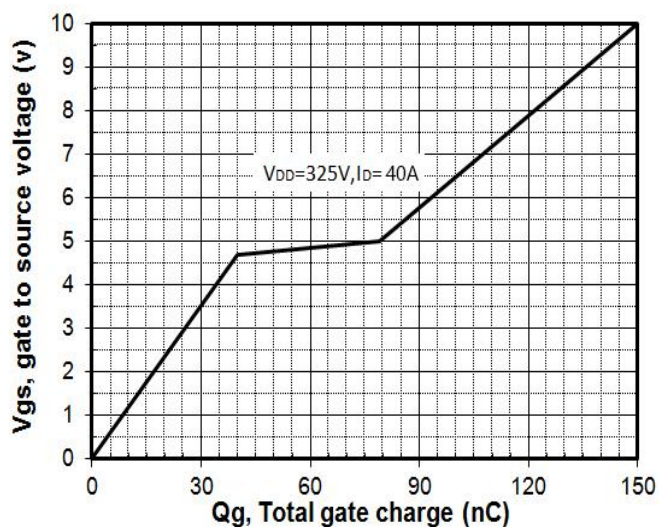


Fig 6: Body Diode Transfer Characteristics

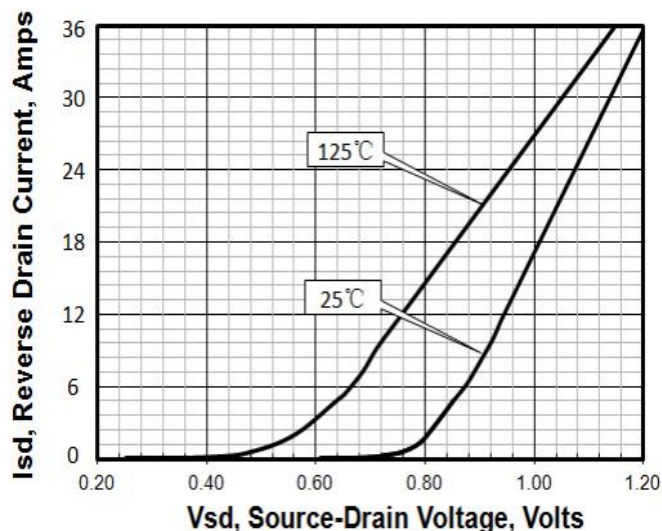


Fig 7: Power Dissipation

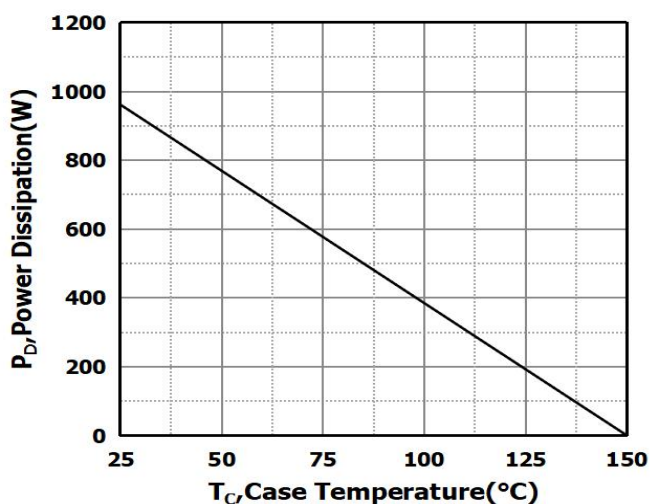


Fig 8: Drain Current Derating

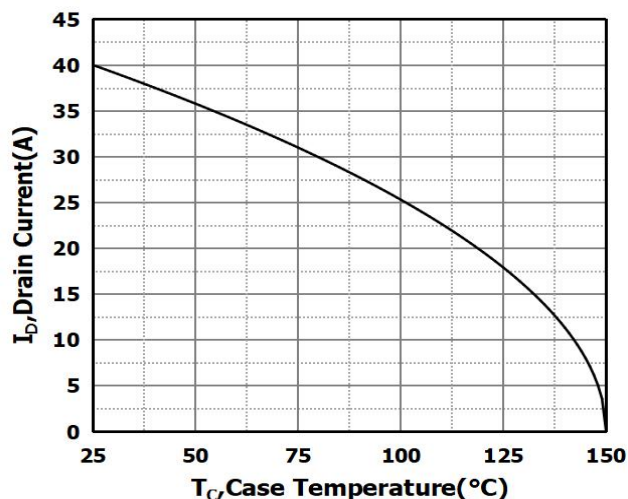


Fig 9: Safe Operating Area

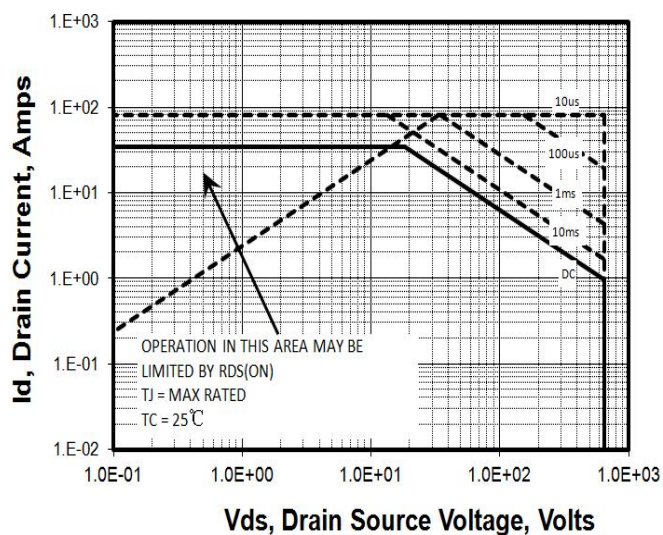


Fig 10: Drain to Source ON Resistance vs Drain Current

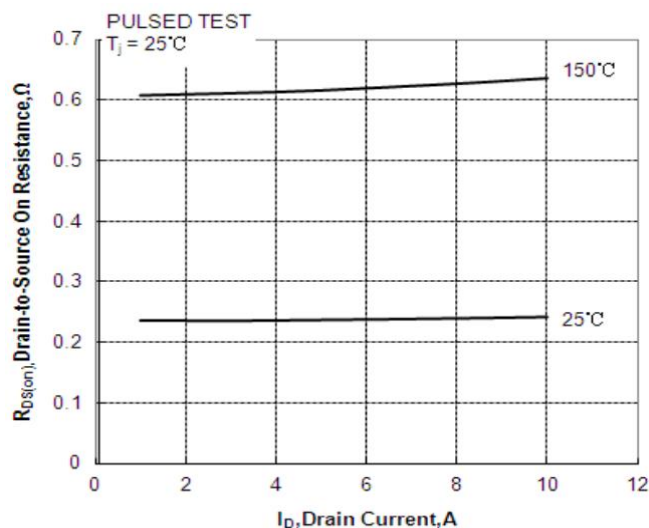
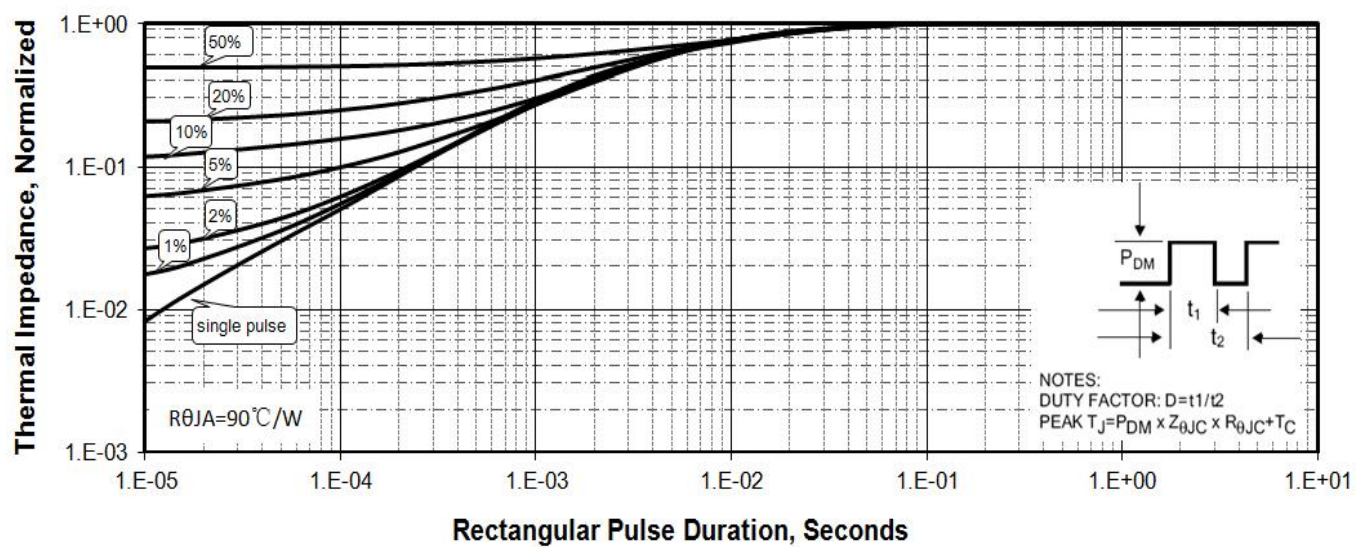
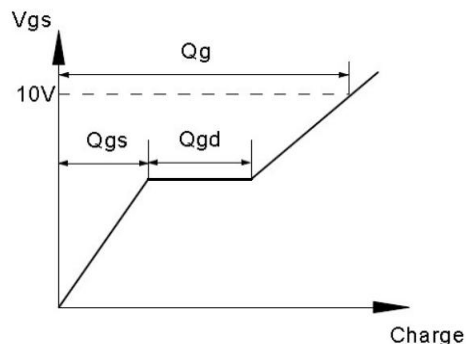
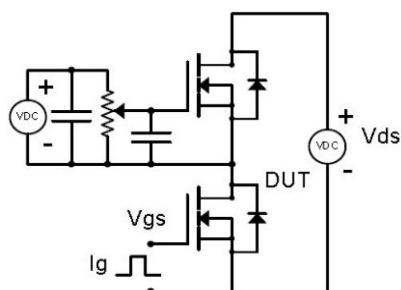


Fig 11: Transient Thermal Response Curve

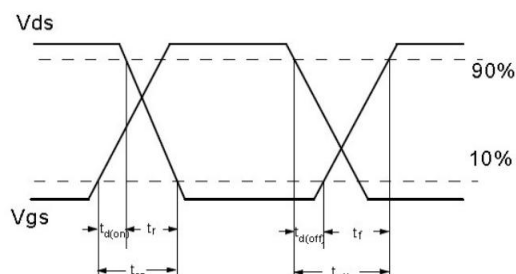
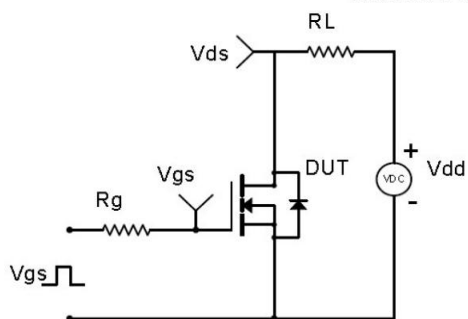


Test Circuit & Waveform

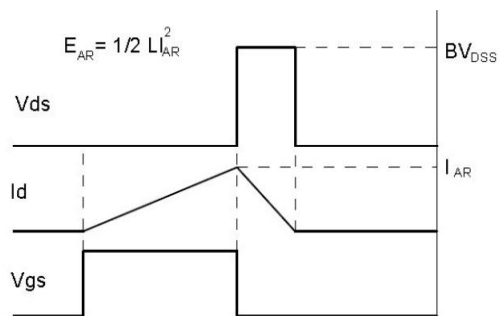
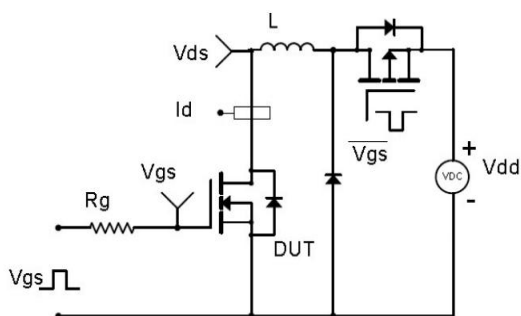
Gate Charge Test Circuit & Waveform



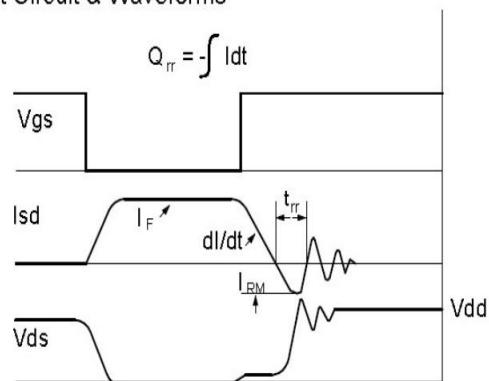
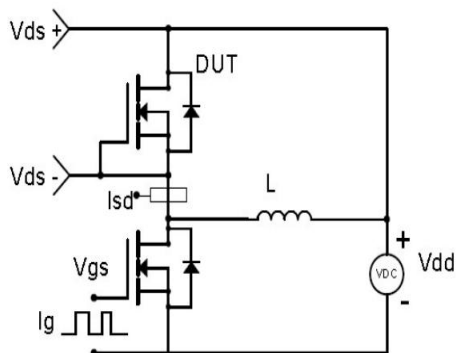
Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



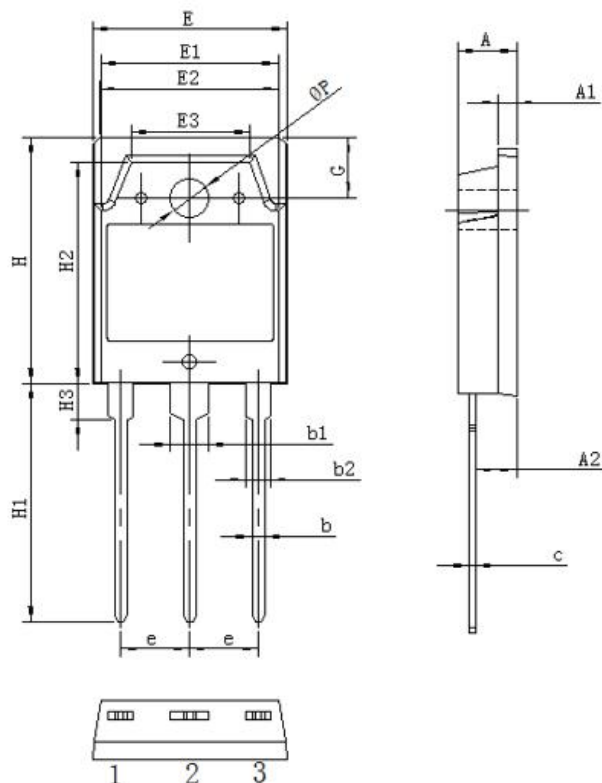
Diode Recovery Test Circuit & Waveforms



Package Information

TO-3PN PACKAGE

基本尺寸



Symbol	单位 mm		
	Min	Nom	Max
A	4.60	4.80	5.00
A1	1.3	1.5	1.7
A2	2.20	2.40	2.60
b	0.80	1.0	1.20
b1	2.90	3.10	3.30
b2	1.90	2.10	2.30
c	0.50	0.60	0.70
e	5.25	5.45	5.65
E	15.2	15.6	16.0
E1	13.2	13.4	13.6
E2	13.1	13.3	13.5
E3	9.1	9.3	9.5
H	19.8	20.0	20.2
H1	19.4	19.8	20.2
H2	18.5	18.7	18.9
H3	2.9	3.1	3.3
G	4.8	5.0	5.2
ΦP	3.00	3.20	3.40

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